 rch N	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/672,391	JAEGER, DENNY
Examiner	Art Unit
   Mylinh Tran	2179

	SEARCHED		
Class	Subclass	Date	Examiner
709	217	1/20/06	TWI
	203		1
175	716		
	723		
709	204	V	
715	763	8/15/06	M
1	764	Ju/	
345		73 7/18/07	rul
	474	'/'	1
715	762		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
(INCLUDING SEARCH	DATE	) EXMR
	4/20/06	
Text search	130(13)	
NPL, EAST, USPAT		
USPGPUB	8115/06	
Texturch	8112100	
EPO, JPO, DEKNER	1	
IBM_TOB	7/18/07	nu
Text rearch		
constted with		
primary thugah		V
		İ